

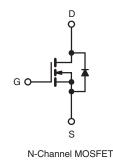
K2520-VB Datasheet N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	200					
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.265				
Q _g (Max.) (nC)	16					
Q _{gs} (nC)	5					
Q _{gd} (nC)	8					
Configuration	Single					

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available





ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	200	- V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I _D	10		
		$T_C = 100 ^{\circ}C$		6.5	A	
Pulsed Drain Current ^a			I _{DM}	32		
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	36	mJ	
Repetitive Avalanche Current ^a			I _{AR}	7.2	А	
Repetitive Avalanche Energy ^a			E _{AR}	3.7	mJ	
Maximum Power Dissipation	T _C =	25 °C	PD	37	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d		
Mounting Torque	6 22 or 1	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF IVI3 SCIEW			1.1	N ⋅ m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 1.0 mH, $R_G = 25 \Omega$, $I_{AS} = 7.2 \text{ A}$ (see fig. 12). c. $I_{SD} \le 9.2 \text{ A}$, dl/dt $\le 110 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.





THERMAL RESISTANCE RATINGS										
PARAMETER	SYMBOL	TYP. MAX.			UNIT					
Maximum Junction-to-Ambient	R _{thJA}	- 65			80 AM					
Maximum Junction-to-Case (Drain)	R _{thJC}	- 4.1				°C/W				
SPECIFICATIONS T _J = 25 °C, unless otherwise noted										
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNIT		
Static										
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$			200	-	-	V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.13	-	V/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	2.0	-	4.0	V		
Gate-Source Leakage	I _{GSS}	, v	$V_{GS} = \pm 20 V$			-	± 100	nA		
	I _{DSS}	V _{DS} =	$V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}$			-	25			
Zero Gate Voltage Drain Current		V _{DS} =160 V	, V _{GS} = 0 V,	$T_J = 150 \ ^\circ C$	-	-	250	μA		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 4.3 A ^b	-	0.265	-	Ω		
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	4.3 A ^b	2.3	-	-	S		
Dynamic										
Input Capacitance	C _{iss}		V _{GS} = 0 V, V _{DS} = 25 V,		-	560	-			
Output Capacitance	C _{oss}				-	260	-			
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	110	-	рF			
Drain to Sink Capacitance	С			-	12	-				
Total Gate Charge	Qg			-	-	16	nC			
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	V _{GS} = 10 V l _D = 9.2 see fid		-	-		4.4		
Gate-Drain Charge	Q _{gd}	-	000 11		-	-	7.7			
Turn-On Delay Time	t _{d(on)}	$\label{eq:V_DD} \begin{split} V_{DD} &= 100 \; \text{V}, \; \text{I}_{D} \text{=} \; 9.2 \; \text{A}, \\ R_{G} &= 18 \; \Omega, \; \text{R}_{D} \text{=} \; 5.2 \; \Omega, \\ & \text{see fig. 10}^{\text{b}} \end{split}$		-	8.8	-	- ns			
Rise Time	t _r			-	30	-				
Turn-Off Delay Time	t _{d(off)}			-	19	-				
Fall Time	t _f			-	20	-				
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH			
Internal Source Inductance	LS			-	7.5	-				
Drain-Source Body Diode Characteristic	cs									
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	10	-	A			
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	32		-		
Body Diode Voltage	V_{SD}	T _J = 25 °C	$T_J = 25 \ ^{\circ}C, \ I_S = 7.2 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 9.2 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	130	260	ns			
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.65	1.3	μC			
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						_D)		
	•	•								

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

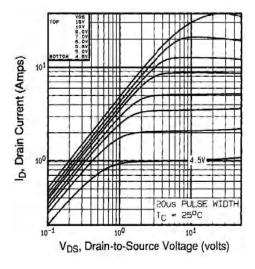


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

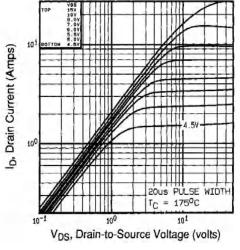


Fig. 2 - Typical Output Characteristics, T_C = 175 $^\circ C$

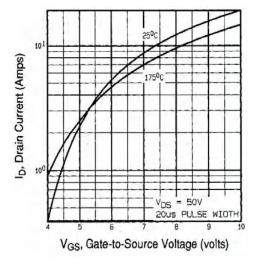


Fig. 3 - Typical Transfer Characteristics

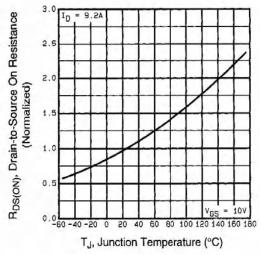


Fig. 4 - Normalized On-Resistance vs. Temperature



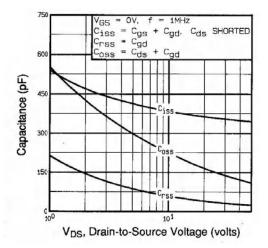


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

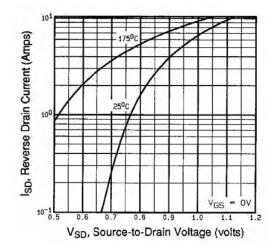


Fig. 7 - Typical Source-Drain Diode Forward Voltage

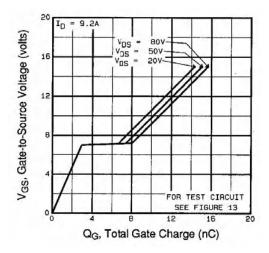


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

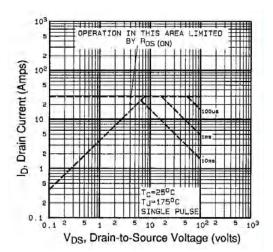


Fig. 5 - Fig. 8 - Maximum Safe Operating Area



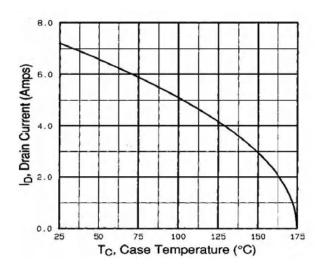


Fig. 9 - Maximum Drain Current vs. Case Temperature

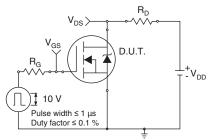


Fig. 10a - Switching Time Test Circuit

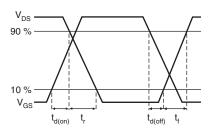
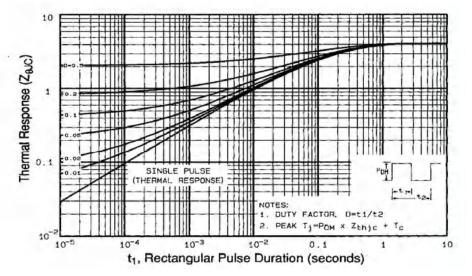
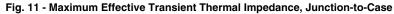


Fig. 10b - Switching Time Waveforms





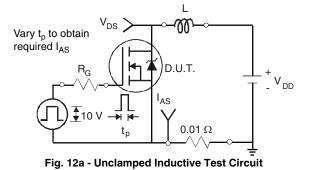
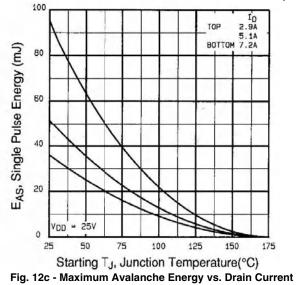
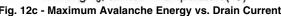


Fig. 12b - Unclamped Inductive Waveforms







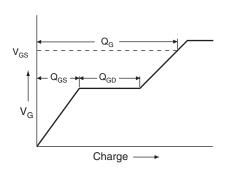
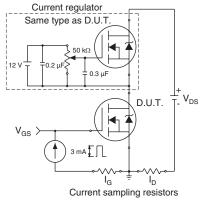
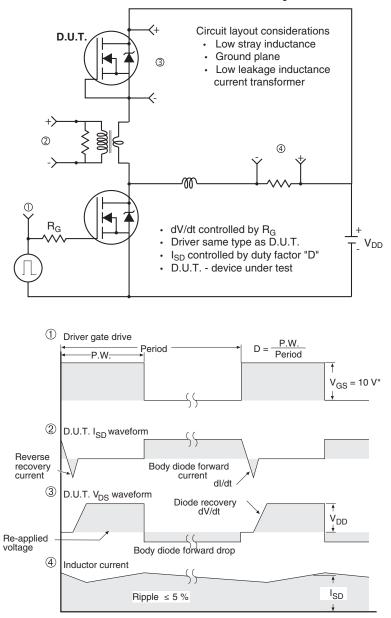


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



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